

# PI6CG33801CZLIEX Datasheet



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DiGi Electronics Part Number PI6CG33801CZLIEX-DG

Manufacturer Diodes Incorporated

Manufacturer Product Number PI6CG33801CZLIEX

Description IC CLOCK GENERATOR 48TQFN

Detailed Description Clock Generator IC 100MHz 1 48-VFQFN Exposed Pa

d



Tel: +00 852-30501935

RFQ Email: Info@DiGi-Electronics.com

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## **Purchase and inquiry**

Manufacturer Product Number:	Manufacturer:
PI6CG33801CZLIEX	Diodes Incorporated
Series:	Product Status:
	Active
DiGi-Electronics Programmable:	Type:
Not Verified	Clock Generator
PLL:	Input:
Yes	CMOS, Crystal
Output:	Number of Circuits:
HCSL	1
Ratio - Input:Output:	Differential - Input:Output:
1:8	No/Yes
Frequency - Max:	Divider/Multiplier:
100MHz	No/No
Voltage - Supply:	Operating Temperature:
3.135V ~ 3.465V	-40°C ~ 85°C (TA)
Mounting Type:	Grade:
Surface Mount	Automotive
Qualification:	Package / Case:
AEC-Q100	48-VFQFN Exposed Pad
Supplier Device Package:	Base Product Number:
48-TQFN (6x6)	PI6CG33801

## **Environmental & Export classification**

8542.39.0001

RoHS Status:	Moisture Sensitivity Level (MSL):
ROHS3 Compliant	1 (Unlimited)
REACH Status:	ECCN:
REACH Unaffected	EAR99
HTSUS:	





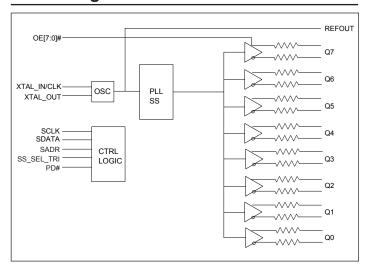
#### 3.3V Very Low Power 8-Output PCle Clock Generator With On-chip Termination

## **Description**

The DIODES PI6CG33801C is an 8-output very low power PCIe Gen1/Gen2/Gen3/Gen4/Gen5/Gen6 clock generator. It uses 25MHz crystal or CMOS reference as an input to generate the 100MHz low power differential HCSL outputs with on-chip terminations. The on-chip termination can save 32 external resistors and make layout easier. An additional buffered reference output is provided to serve as a low noise reference for other circuitry.

It uses Diodes' proprietary PLL design to achieve very low jitter that meets PCIe Gen1/Gen2/Gen3/Gen4/Gen5/Gen6 requirements. It also provides various options such as different slew rate and amplitude through SMBUS so that users can configure the device easily to get the optimized performance for their individual boards. The device also supports selectable spread-spectrum options to reduce EMI for various applications.

## **Block Diagram**



#### **Features**

- 3.3V Supply Voltage
- Crystal/CMOS input: 25 MHz
- 8 differential low power HCSL outputs with on-chip termination
- Default  $Z_{OUT} = 100\Omega$
- Individual output enable
- Reference CMOS output
- Programmable slew rate and output amplitude for each output
- Differential outputs blocked until PLL is locked
- Selectable 0%, -0.25% or -0.5% spread on differential outputs
- Strapping pins or SMBus for configuration
- Differential Output-To-Output Skew <60ps
- Very-Low Jitter Outputs
  - Differential Cycle-To-Cycle Jitter <50ps</li>
  - PCIe Gen1/Gen2/Gen3/Gen4/Gen5/Gen6 Compliant
  - CMOS REFOUT Phase Jitter
    - <0.3ps RMS, SSC off
    - <1.5ps RMS, SSC on
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- For automotive applications requiring specific change control (i.e. parts qualified to AEC-Q100/101/104/200, PPAP capable, and manufactured in IATF 16949 certified facilities), please contact us or your local Diodes representative.

https://www.diodes.com/quality/product-definitions/

- Packaging (Pb-free & Green):
  - 48-lead 6×6mm TQFN

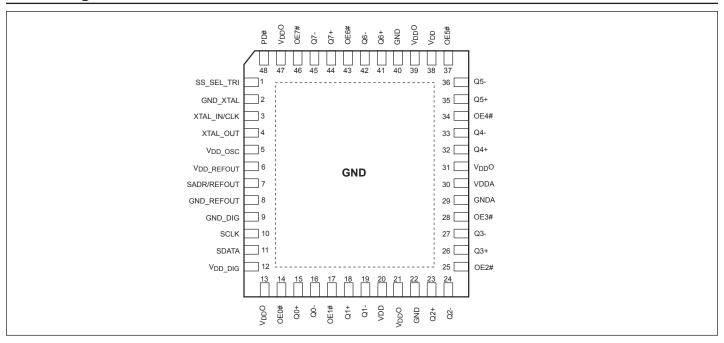
#### Notes

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.





## **Pin Configuration**



## **Pin Description**

Pin #	Pin Name	Ту	pe	Description
1	SS_SEL_TRI	Input	Tri-level	Latched select input to select spread spectrum amount at initial power up. 1 = -0.5% spread, M = Spread Off, 0 = Spread Off. This pin has both internal pull-up and pull-down. Refer to SMBUS byte_1 bit 4, 3 = '01' to get -0.25% spread.
2	GND_XTAL	Power		Ground for oscillator circuit
3	XTAL_IN/CLK	Input		Crystal input or CMOS reference input
4	XTAL_OUT	Output		Crystal output
5	V <sub>DD</sub> _OSC	Power		Power supply for oscillator circuitry, nominal 3.3V
6	V <sub>DD</sub> _REFOUT	Power		Power supply for buffered CMOS output
7	SADR/REFOUT	Input/ Output	CMOS	Latch to select SMBus Address or LVCMOS REFOUT. This pin has an internal pull-down
8	GND_REFOUT	Power		Ground for REFOUT
9	GND_DIG	Power		Ground for digital circuitry
10	SCLK	Input	CMOS	SMBUS clock input, 3.3V tolerant
11	SDATA	Input/ Output	CMOS	SMBUS Data line, 3.3V tolerant
12	V <sub>DD</sub> _DIG	Power		Power supply for digital circuitry, nominal 3.3V
13, 21, 31, 39, 47	$V_{\mathrm{DDO}}$	Power		Power supply for differential outputs





Pin#	Pin Name	Ту	pe	Description
14	OE0#	Input	CMOS	Active low input for enabling Q0 pair. This pin has an internal pull-down. 1 = disable outputs, 0 = enable outputs
15	Q0+	Output	HCSL	Differential true clock output
16	Q0-	Output	HCSL	Differential complementary clock output
17	OE1#	Input	CMOS	Active low input for enabling Q1 pair. This pin has an internal pull-down. 1 = disable outputs, 0 = enable outputs
18	Q1+	Output	HCSL	Differential true clock output
19	Q1-	Output	HCSL	Differential complementary clock output
20, 38	$V_{\mathrm{DD}}$	Power		Power supply, nominal 3.3V
22, 40	GND	Power		Ground
23	Q2+	Output	HCSL	Differential true clock output
24	Q2-	Output	HCSL	Differential complementary clock output
25	OE2#	Input	CMOS	Active low input for enabling Q2 pair. This pin has an internal pull-down. 1 = disable outputs, 0 = enable outputs
26	Q3+	Output	HCSL	Differential true clock output
27	Q3-	Output	HCSL	Differential complementary clock output
28	OE3#	Input	CMOS	Active low input for enabling Q3 pair. This pin has an internal pull-down. 1 = disable outputs, 0 = enable outputs
29	GNDA	Power		Ground for analog circuitry
30	$V_{\mathrm{DDA}}$	Power		Power supply for analog circuitry
32	Q4+	Output	HCSL	Differential true clock output
33	Q4-	Output	HCSL	Differential complementary clock output
34	OE4#	Input	CMOS	Active low input for enabling Q4 pair. This pin has an internal pull-down. $1 = \text{disable outputs}$ , $0 = \text{enable outputs}$
35	Q5+	Output	HCSL	Differential true clock output
36	Q5-	Output	HCSL	Differential complementary clock output
37	OE5#	Input	CMOS	Active low input for enabling Q5 pair. This pin has an internal pull-down. 1 = disable outputs, 0 = enable outputs
41	Q6+	Output	HCSL	Differential true clock output
42	Q6-	Output	HCSL	Differential complementary clock output
43	OE6#	Input	CMOS	Active low input for enabling Q6 pair. This pin has an internal pull-down. 1 = disable outputs, 0 = enable outputs
44	Q7+	Output	HCSL	Differential true clock output
45	Q7-	Output	HCSL	Differential complementary clock output
46	OE7#	Input	CMOS	Active low input for enabling Q7 pair. This pin has an internal pull-down. 1 = disable outputs, 0 = enable outputs
48	PD#	Input	CMOS	Input notifies device to sample latched inputs and start up on first high assertion. Low enters Power Down Mode, subsequent high assertions exit Power Down Mode. This pin has internal pull-up resistor.





#### **Table 1. SMBus Address Selection**

	SADR	Address	+Read/Write Bit
Chata of CADD on Contamplication of DD#	0	1101000	X
State of SADR on first application of PD#	1	1101010	X

## Table 2. Power Management<sup>(3)</sup>

PD#	SMBus OE bit	OEn#	Qn+	Qn-	REFOUT
0	X	X	Low <sup>(1)</sup>	Low <sup>(1)</sup>	HiZ <sup>(2)</sup>
1	1	0	Running	Running	Running
1	1	1	Disabled <sup>(1)</sup>	Disabled <sup>(1)</sup>	Running
1	0	X	Disabled <sup>(1)</sup>	Disabled <sup>(1)</sup>	Disabled <sup>(4)</sup>

- 1. The output state is set by B11[1:0] (Low/Low default)
- 2. REF is Hi-Z until the 1st assertion of PD# high. After this, when PD# is low, REF is disabled. If Byte3, bit 5 = 1, then REF is running
- 3. Input High/ Low defined at default values for device
- 4. See SMBUs Byte 3, bit 4





## **Maximum Ratings**

(Above which useful life may be impaired. For user guidelines, not tested.)

Storage Temperature65°C to +150°C
Supply Voltage to Ground Potential, $V_{\mathrm{DDxx}}$ 0.5V to +4.6V
Input Voltage –0.5V to $V_{\mbox{\scriptsize DD}}$ +0.5V, not exceed 4.6V
SMBus, Input High Voltage
ESD Protection (HBM)
Max Junction Temperature+125°C

**Note:** Stresses greater than those listed under MAXI-MUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

#### **Operating Conditions**

Temperature = T<sub>A</sub>; Supply voltages per normal operation conditions; See test circuits for the load conditions

Symbol	Parameters	Conditions	Min.	Тур.	Max.	Units
V <sub>DD</sub> , V <sub>DDA</sub> , V <sub>DD</sub> OSC, V <sub>DD</sub> DIG,	Power Supply Voltage		3.135	3.3	3.465	V
$V_{DDO}$	Output Power Supply Voltage		1.0	3.3	3.465	V
V <sub>DD_REFOUT</sub>	Reference Output Power Supply Voltage		3.135	3.3	3.465	V
$I_{DDA}$	Analog Power Supply Current	All outputs active @100MHz		22	25	mA
$I_{DD}$	Power Supply Current	All $V_{DD}$ , except $V_{DDA}$ and $V_{DDO}$ , All outputs active @100MHz		20	25	mA
$I_{DDO}$	Power Supply Current for Outputs <sup>(3)</sup>	All outputs active @100MHz		29	34	mA
I <sub>DDA_WL</sub>	Analog Power Supply Wake-on- LAN <sup>(1)</sup> Current	Q outputs off, REF output running		0.5	1	mA
I <sub>DD_WL</sub>	Power Supply Wake-on-LAN <sup>(1)</sup> Current	All $V_{DD}$ , except $V_{DDA}$ and $V_{DDO}$ , $Q$ outputs off, REF output running		3	6	mA
I <sub>DDO_WL</sub>	Power Supply Wake-on-LAN <sup>(1)</sup> Current for Outputs	Q outputs off, REF output running		0.04	0.1	mA
I <sub>DDA_PD</sub>	Analog Power Supply Power Down <sup>(2)</sup> Current	All outputs off		0.5	1	mA
I <sub>DD_PD</sub>	Power Supply Power Down <sup>(2)</sup> Current	All outputs off		1	2	mA
I <sub>DDO_PD</sub>	Power Supply Current Power Down <sup>(2)</sup> for Outputs	All outputs off		0.05	0.1	mA
$T_{A}$	Ambient Temperature	Industrial grade	-40		85	°C

- 1. Wake-on-LAN mode: PD# = '0' Byte 3, bit 5 = '1'
- 2. Power down mode: PD# = '0' Byte 3, bit 5 = '0'
- 3. Output drive 5 inch trace.





## **Input Electrical Characteristics**

Symbol	Parameters	Conditions	Min.	Тур.	Max.	Units
R <sub>pu</sub>	Internal pull up resistance			120		ΚΩ
R <sub>dn</sub>	Internal pull down resistance			120		ΚΩ
$C_{\mathrm{XTAL}}$	Internal capacitance on X_IN and X_OUT pins			8		pF
L <sub>PIN</sub>	Pin inductance				7	nН

## **Crystal Characteristic**

Parameters	Description	Min.	Тур	Max.	Units
OSCmode	Mode of Oscillation	F	undamenta	al	
FREQ	Frequency		25		MHz
ESR <sup>(1)</sup>	Equivalent Series Resistance			50	Ω
Cload	Load Capacitance		8		pF
Cshunt	Shunt Capacitance			7	pF
	Drive Level			200	uW

#### Note:

#### **SMBus Electrical Characteristics**

Temperature = T<sub>A</sub>; Supply voltages per normal operation conditions; See test circuits for the load conditions

Symbol	Parameters	Conditions	Min.	Тур.	Max.	Units
V <sub>DDSMB</sub>	Nominal bus voltage		2.7		3.6	V
		SMBus, $V_{DDSMB} = 3.3V$	2.1		3.6	
V <sub>IHSMB</sub>	SMBus Input High Voltage	SMBus, V <sub>DDSMB</sub> < 3.3V	0.65 V <sub>DDSMB</sub>			V
37	CMD L	SMBus, $V_{DDSMB} = 3.3V$			0.8	V
V <sub>ILSMB</sub>	SMBus Input Low Voltage	SMBus, V <sub>DDSMB</sub> < 3.3V			0.8	,
I <sub>SMBSINK</sub>	SMBus sink current	SMBus, at V <sub>OLSMB</sub>	4			mA
V <sub>OLSMB</sub>	SMBus Output Low Voltage	SMBus, at I <sub>SMBSINK</sub>			0.4	V
f <sub>MAXSMB</sub>	SMBus operating frequency	Maximum frequency			500	kHz
t <sub>RMSB</sub>	SMBus rise time	(Max $V_{IL}$ - 0.15) to (Min $V_{IH}$ + 0.15)			1000	ns
t <sub>FMSB</sub>	SMBus fall time	(Min $V_{IH}$ + 0.15) to (Max $V_{IL}$ - 0.15)			300	ns

<sup>1.</sup> ESR value is dependent upon frequency of oscillation





## **Spread Spectrum Characteristic**

Temperature = T<sub>A</sub>; Supply voltages per normal operation conditions; See test circuits for the load conditions

Symbol	Parameters	Conditions	Min.	Тур.	Max.	Units
$f_{MOD}$	SS Modulation Frequency	Triangular modulation	30	31.8	33	kHz

#### **LVCMOS DC Electrical Characteristics**

Temperature = T<sub>A</sub>; Supply voltages per normal operation conditions; See test circuits for the load conditions

Symbol	Parameters	Conditions	Min.	Тур.	Max.	Units
V <sub>IH</sub>	Input High Voltage	Single-ended inputs, except SMBus	0.75 V <sub>DD</sub>		V <sub>DD</sub> +0.3	V
$V_{IM}$	Input Mid Voltage	SS_SEL_TRI	$0.4 V_{ m DD}$	$0.5V_{ m DD}$	$0.6 \mathrm{V}_\mathrm{DD}$	V
$V_{IL}$	Input Low Voltage	Single-ended inputs, except SMBus	-0.3		0.25 V <sub>DD</sub>	V
$I_{IH}$	Input High Current	Single-ended inputs, $V_{IN} = V_{DD}$			5	μΑ
$I_{IL}$	Input Low Current	Single-ended inputs, $V_{IN} = 0V$	-5			μΑ
$I_{IH}$	Input High Current	Single-ended inputs with pull up / pull down resistor, $V_{\rm IN} = V_{\rm DD}$			50	μΑ
$I_{IL}$	Input Low Current	Single-ended inputs with pull up / pull down resistor, $V_{\rm IN} = 0V$	-50			μΑ
V <sub>OH</sub>	Output High Voltage	REFOUT, except SMBus; $I_{OH} = -2mA$	0.8 x V <sub>DD</sub> _ Refout			V
V <sub>OL</sub>	Output Low Voltage	REFOUT, except SMBus; $I_{OL} = 2mA$			$0.2 \text{ x}$ $V_{DD_{-}}$ REFOUT	V
R <sub>OUT</sub>	CMOS Output impedance			20		Ω
C <sub>IN</sub>	Input Capacitance		1.5		5	pF

#### **LVCMOS AC Characteristics**

Temperature = T<sub>A</sub>; Supply voltages per normal operation conditions; See test circuits for the load conditions

Symbol	Parameters	Conditions	Min.	Тур.	Max.	Units
$f_{INPUT}$	Input Frequency	XTAL_IN/CLK		25		MHz
t <sub>RIN</sub>	Input rise time	Single-ended inputs			5	ns
$t_{\rm FIN}$	Input fall time	Single-ended inputs			5	ns
t <sub>STAB</sub>	Clock stabilization	From Power-Up and after input clock stabilization or de-assertion of PD# to 1st clock		0.75	1	ms
t <sub>OELAT</sub>	Output enable latency	Q start after OE# assertion Q stop after OE# deassertion	1		3	clocks





Symbol	Parameters	Conditions	Min.	Тур.	Max.	Units
t <sub>PDLAT</sub>	PD# de-assertion	Differential outputs enable after PD# de-assertion		25	300	us
t <sub>PERIOD</sub>	REFOUT clock period	REFOUT, assume input is at 25MHz		40		ns
$f_{ACC}$	REFOUT frequency accuracy <sup>(1)</sup>	REFOUT, long term accuracy to input		0		ppm
		Byte 3 = 1F, 20% to 80% of $V_{D-}$ DREF	0.9	1.4	2	V/ns
4.	REFOUT slew rate <sup>(1)</sup>	Byte 3 = 5F, 20% to 80% of $V_{D-}$ DREF	1.5	2.4	3.2	V/ns
t <sub>SLEW</sub>	REFOUT SIEW Fate	Byte 3 = 9F, 20% to 80% of $V_{D-}$ DREF	2	3	3.8	V/ns
		Byte 3 = DF, 20% to 80% of $V_{D-}$ DREF	2.3	3.2	4	V/ns
$t_{DC}$	REFOUT Duty Cycle <sup>(1)</sup>	$V_T = V_{\rm DD}$ /2 V, driven by a Xtal	45	50	55	%
t <sub>DCDIS</sub>	REFOUT Duty Cycle Distortion	$V_T = V_{\rm DD}$ /2 V, driven by an external source	-2	0	+2	%
t <sub>JITCC</sub>	REFOUT cycle-cycle jitter	$V_T = V_{\rm DD}$ /2 V, driven by a Xtal		70	150	ps
	DEPOLIT DI LUI DIMO	12kHz to 5MHz, SSC off, driven by a Xtal		0.16	0.3	ps
tjiтрн	REFOUT Phase Jitter, RMS	12kHz to 5MHz, SSC on, driven by a Xtal		0.9	1.5	ps
		1kHz offset, driven by a Xtal		-149	-135	dBc/Hz
t <sub>JITN</sub>	Noise floor	10kHz offset to Nyquist, driven by a Xtal		-158	-140	dBc/Hz

#### Note:

1. Guaranteed by design and characterization, not 100% tested in production





## **HCSL Output Characteristics**

Temperature = T<sub>A</sub>; Supply voltages per normal operation conditions; See test circuits for the load conditions

Symbol	Parameters	Condition	Min.	Тур.	Max.	Units
V <sub>OH</sub>	Output Voltage High <sup>(1)</sup>	Statistical measurement on	660	784	850	mV
V <sub>OL</sub>	Output Voltage Low <sup>(1)</sup>	single-ended signal using oscilloscope math function	-150		150	mV
V <sub>OMAX</sub>	Output Voltage Maximum <sup>(1)</sup>	Measurement on single ended		816	1150	mV
V <sub>OMIN</sub>	Output Voltage Minimum <sup>(1)</sup>	signal using absolute value	-300	-42		mV
V <sub>OC</sub>	Output Cross Voltage <sup>(1,2,4)</sup>		250	430	550	mV
DV <sub>OC</sub>	V <sub>OC</sub> Magnitude Change <sup>(1,2,5)</sup>			30	140	mV

#### Note:

- 1. At default SMBUS amplitude settings
- 2. Guaranteed by design and characterization, not 100% tested in production
- 3. Measured from differential waveform
- 4. This one is defined as voltage where Q+ = Q- measured on a component test board and only applied to the differential rising edge
- 5. The total variation of all Vcross measurements in any particular system. This is a subset of Vcross\_min/max allowed.

## **HCSL Output AC Characteristics**

Temperature = T<sub>A</sub>; Supply voltages per normal operation conditions; See test circuits for the load conditions

Symbol	Parameters	Condition	Min.	Тур.	Max.	Units
f <sub>OUT</sub>	Output Frequency			100		MHz
	Slew rate <sup>(1,2,3)</sup>	Scope averaging on fast setting	2.5	3.2	4	V/ns
t <sub>RF</sub>	Siew rate	Scope averaging on slow setting	2.2	3	3.7	V/ns
Dt <sub>RF</sub>	Slew rate matching <sup>(1,2,4)</sup>	Scope averaging on		7	15	%
$t_{DC}$	Duty Cycle <sup>(1,2)</sup>	Measured differentially, PLL Mode	45	50	55	%
t <sub>SKEW</sub>	Output Skew <sup>(1,2)</sup>	Averaging on, $V_T = 50\%$		20	60	ps
tj <sub>c-c</sub>	Cycle to cycle jitter <sup>(1,2)</sup>			20	50	ps

- $1. \quad Guaranteed \ by \ design \ and \ characterization-not \ 100\% \ tested \ in \ production.$
- 2. Measured from differential waveform.
- 3. Slew rate is measured through the Vswing voltage range centered around differential 0V, within  $\pm 150 \text{mV}$  window.
- 4. It is measured using a ±75mV window centered on the average cross point.





## **PCIe Common Clock (CC) Architecture Jitter**

Symbol	Parameters	Condition	Min.	Тур.	Max.	Spec Limit	Units
		PCIe 1.0		20	30	86	ps (pkpk)
		PCIe 2.0 Low Band, 10kHz < f < 1.5MHz (PLL BW 5-16MHz or 8-5MHz, CDR = 10MHz)		0.1	0.2	3	ps
t <sub>j</sub> PHASE	Integrated phase jitter (RMS)	PCIe 2.0 High Band, 1.5MHz < f < Nyquist (50MHz); (PLL BW 5-16MHz or 8-5MHz, CDR = 10MHz)		0.4	0.5	3.1	ps
		PCIe 3.0 (PLL BW 2-4MHz or 2-5MHz, CDR = 10MHz)		0.15	0.2	1	ps
		PCIe 4.0 (PLL BW 2-4MHz or 2-5MHz, CDR = 10MHz)		0.15	0.2	0.5	ps
		PCIe 5.0		0.05	0.06	0.15	ps
		PCIe 6.0		0.03	0.04	0.1	ps

## **PCIe Independent Reference Clock Architecture Jitter**

Symbol	Parameters	Condition	Min.	Тур.	Max.	Spec Limit	Units
		PCIe 3.0 SRIS (PLL BW 2-4MHz or 2-5MHz, CDR = 10MHz)		0.15	0.25		ps
t <sub>j</sub> PHASE	Integrated phase jitter (RMS)	PCIe 4.0 SRIS (PLL BW 2-4MHz or 2-5MHz, CDR = 10MHz)		0.15	0.25		ps
		PCIe 5.0 SRIS		0.04	0.07		ps
		PCIe 6.0 SRIS		0.03	0.05		ps





**Differential Output Clock Periods - Spread Spectrum Disabled** 

	Measurement Window										
Center	1 clock	1 us	0.1 s	0.1 s	0.1 s	1 us	1 clock				
Freq. MHz	-c2c jitter AbsPer Min	-SSC Short- term Avg. Min	-ppm Long- term Avg. min	0 ppm Pe- riod Nomi- nal	+ppm Long- term Avg. max	+SSC Short- term Avg. Max	-c2c jitter AbsPer Max	Units			
100.00	9.94900		9.99900	10.00000	10.00100		10.05100	ns			

Differential Output Clock Periods - Spread Spectrum Enabled

		-	Mea	surement Win	dow			
Center	1 clock	1 us	0.1 s	0.1 s	0.1 s	1 us	1 clock	
Freq. MHz	-c2c jitter AbsPer Min	-SSC Short- term Avg. Min	-ppm Long- term Avg. min	0 ppm Pe- riod Nomi- nal	+ppm Long- term Avg. max	+SSC Short- term Avg. Max	-c2c jitter AbsPer Max	Units
99.75	9.94906	9.99906	10.02406	10.02506	10.02607	10.05107	10.10107	ns

- 1. Guaranteed by design and characterization, not 100% tested in production
- 2. All long term accuracy and clock period specifications are guaranteed assuming REF is trimmed to 25.00MHz





#### **SMBus Serial Data Interface**

PI6CG33801C is a slave only device that supports block read and block write protocol using a single 7-bit address and read/write bit as shown below.

Read and write block transfers can be stopped after any complete byte transfer.

#### **Address Assignment**

A6	A5	A4	A3	A2	A1	A0	R/W
1	1	0	1	0	SADR	0	1/0

Note: SMBus address is latched on SADR pin

#### **How to Write**

1 bit	7 bits	1 bit	1 bit	8 bits	1 bit	8 bits	1 bit	8 bits	1 bit	8 bits	1 bit	1 bit
Start bit	Add.	W(0)	Ack	Beginning Byte loca- tion = N	Ack	Data Byte count = X	Ack	Beginning Data Byte (N)	Ack	 Data Byte (N+X-1)	Ack	Stop bit

#### How to Read

1 bit	7 bits	1 bit	1 bit	8 bits	1 bit	1 bit	7 bits	1 bit	1 bit	8 bits	1 bit	8 bits	1 bit
Start bit	Address	W(0)	Ack	Beginning Byte loca- tion = N	Ack	Repeat Start bit	Address	R(1)	Ack	Data Byte count = X	Ack	Beginning Data Byte (N)	Ack

8 bits	1 bit	1 bit
Data Byte	NAck	Stop bit
(N+X-1)	INACK	Stop bit

Byte 0	Byte 0: Output Enable Register						
Bit	Control Function	Description	Туре	Power Up Condition	0	1	
7	Q7_OE	Q7 output enable	RW	1		Pin Control	
6	Q6_OE	Q6 output enable	RW	1		Pin Control	
5	Q5_OE	Q5 output enable	RW	1		Pin Control	
4	Q4_OE	Q4 output enable	RW	1	Can D11[1.0]	Pin Control	
3	Q3_OE	Q3 output enable	RW	1	See B11[1:0]	Pin Control	
2	Q2_OE	Q2 output enable	RW	1		Pin Control	
1	Q1_OE	Q1 output enable	RW	1		Pin Control	
0	Q0_OE	Q0 output enable	RW	1		Pin Control	

<sup>1.</sup> A low on these bits will override the OE# pins and force the differential outputs to the state indicated by B11[1:0] (Low/ Low default)





Byte 1: SS Spread Spectrum and Control Register							
Bit	Control Function	Description	Туре	Power Up Condition	0	1	
7	SSENRB1	SS Enable Readback Bit1	R	Latch	'00' for SS_SEL	_TRI = '0',	
6	SSENRB0	SS Enable Readback Bit0	R	Latch	'10' for SS_SEL_TRI = 'M' '11' for SS_SEL_TRI = '1'		
5	SSEN_SWCTR	Enable SW control of SS	RW	0	Values in B1[7:6] control SS amount	Values in B1[4:3] control SS amount	
4	SSENSW1	SS enable SW control Bit1	RW <sup>(1)</sup>	0	'00' = SS off, '01	' = -0.25% SS,	
3	SSENSW0	SS enable SW control Bit0	RW <sup>(1)</sup>	0	'10' = SS off, '11'	= -0.5% SS	
2	Reserved			1			
1	Amplitude1	Control output amplitude	RW	1	'00' = 0.6V, '01' = 0.68V, '10' = 0.75V, '11' = 0.85V		
0	Amplitude0	Control output amplitude	RW	0			

<sup>1.</sup> Spread must be selected OFF or ON with the hardware latch pin. These bits should not be used to turn spread ON or OFF after power up. These bits can be used to change the spread amount, and B1[5] must be set to a 1 for these bits to have any effect on the part. If These bits are used to turn spread OFF or ON, the system will need to be reset.

Byte 2	: Differential Output S	lew Rate Control Register				
Bit	Control Function	Description	Туре	Power Up Condition	0	1
7	SLEWRATECTR_Q7	Control slew rate of Q7	RW	1	Slow setting	Fast setting
6	SLEWRATECTR_Q6	Control slew rate of Q6	RW	1	Slow setting	Fast setting
5	SLEWRATECTR_Q5	Control slew rate of Q5	RW	1	Slow setting	Fast setting
4	SLEWRATECTR_Q4	Control slew rate of Q4	RW	1	Slow setting	Fast setting
3	SLEWRATECTR_Q3	Control slew rate of Q3	RW	1	Slow setting	Fast setting
2	SLEWRATECTR_Q2	Control slew rate of Q2	RW	1	Slow setting	Fast setting
1	SLEWRATECTR_Q1	Control slew rate of Q1	RW	1	Slow setting	Fast setting
0	SLEWRATECTR_Q0	Control slew rate of Q0	RW	1	Slow setting	Fast setting





Byte 3: REF Control Register							
Bit	Control Function	Description	Туре	Power Up Condition	0	1	
7	DEECLEMID ATE	Classicate control for DEE	RW	0	'00' = 1.4V/ns '0	01' = 2.4V/ns,	
6	REFSLEWRATE	Slew rate control for REF	RW	1	'10' = 3V/ns, '11	s' = 3.2 V/ns	
5	REF_PDSTATE	Wake-on-Lan enable for REF	RW	0	REF = Dis- abled in PD state <sup>(1)</sup>	REF = run- ning in PD state	
4	REF_OE	Output enable for REF	RW	1	REF = Dis- abled <sup>(1)</sup>	REF = run- ning	
3	Reserved			1			
2	Reserved			1			
1	Reserved			1			
0	Reserved			1			

#### Note:

<sup>1.</sup> The disabled state depends on Byte11[1:0]. '00' = Low, '01'=HiZ, '10'=Low, '11'=High

Byte 4: Reserved							
Bit	<b>Control Function</b>	Description	Туре	Power Up Condition	0	1	
7:0	Reserved			0x40			

#### Byte 5: Revision and Vendor ID Register

Bit	Control Function	Description	Туре	Power Up Condition	0	1	
7	RID3		R	0			
6	RID2	D ID	R	0	D 0000		
5	RID1	evision ID	R	0	Rev = 0000		
4	RID0		R	0			
3	PVID3		R	0			
2	PVID2	W 1 12	R	0	Diodes = 0011		
1	PVID1	Vendor ID	R	1			
0	PVID0		R	1			





Byte 6	: Device Type/Device	ID Register					
Bit	Control Function	Description	Туре	Power Up Condition	0	1	
7	DTYPE1	D : 1	R	0	'00' = CG, '01	' = ZDB,	
6	DTYPE0	Device type	R	0	'10' = Reserve	ed, '11' = NZDB	
5	DID5		R	0			
4	DID4		R	0			
3	DID3	Di ID	R	1	0010001:	0011	
2	DID2	Device ID	R	0	001000 binaı	ту, 08нех	
1	DID1		R	0			
0	DID0		R	0			
Byte 7	: Byte Count Register		·				
Bit	Control Function	Description	Туре	Power Up Condition	0	1	
7	Reserved			0			
6	Reserved			0			
5	Reserved			0			
4	BC4		RW	0			
3	BC3		RW	1	Writing to th	is register will	
2	BC2	Byte count programming	RW	0		w many bytes will	
1	BC1		RW	0	be read back	default is 8 bytes	
0	BC0		RW	0			
Byte 8	and 9: Reserved						
Bit	Control Function	Description	Туре	Power Up Condition	0	1	
7.0	D 1			B8 = 0x36			
7:0	Reserved			B9 = 0x00			
Byte 1	0: PD Restore						
Bit	Control Function	Description	Туре	Power Up Condition	0	1	
7	Reserved			0			
6	PD Restore	PD Restore to default configuration	RW	1	Clear PD Config	Keep PD Config	
5:0	Reserved			0			





Byte 1	1: Stop Control					
Bit	Control Function	Description	Туре	Power Up Condition	0	1
7:2	Reserved			0		
1	STP1	Tural Compliment DIF Output Disable Sets	RW	0	00 = Low/Low	10 = High/ Low
0	STP0	True/ Compliment DIF Output Disable Sate	RW	0	01 = HiZ/HiZ	11 = Low/ High
Byte 1	2: Impedance Control					
Bit	Control Function	Description	Type	Power Up Condition	0	1
7	Q3_Zout1	Q3 Zout	RW			
6	Q3_Zout0	Q3 Zout	RW			
5	Q2_Zout1	Q2 Zout	RW	10	00 = Reserved $01 = 85\Omega$ $10 = 100\Omega$ 11 = Reserved	
4	Q2_Zout0	Q2 Zout	RW			
3	Q1_Zout1	Q1 Zout	RW	10		
2	Q1_Zout0	Q1 Zout	RW			
1	Q0_Zout1	Q0 Zout	RW			
0	Q0_Zout0	Q0 Zout	RW			
Byte 1	3: Impedance Control					
Bit	Control Function	Description	Type	Power Up Condition	0	1
7	Q7_Zout1	Q7 Zout	RW			
6	Q7_Zout0	Q7 Zout	RW			
5	Q6_Zout1	Q6 Zout	RW		00 = Reserved	
4	Q6_Zout0	Q6 Zout	RW	10	$01 = 85\Omega$	
3	Q5_Zout1	Q5 Zout	RW	10	$10 = 100\Omega$	
2	Q5_Zout0	Q5 Zout	RW		11 = Reserved	
1	Q4_Zout1	Q4 Zout	RW			
0	Q4_Zout0	Q4 Zout	RW			





Byte 1	4: OE Termination Co	ntrol				
Bit	Control Function	Description	Туре	Power Up Condition	0	1
7	OE3_term1	OE3 Pull up or down	RW	0	00 = None	10 = Pullup
5	OE3_term0	OE3 Pull up or down	RW	1	01 = Pull- down	11 = Pullup and Down
5	OE2_term1	OE2 Pull up or down	RW	0	00 = None	10 = Pullup
1	OE2_term0	OE2 Pull up or down	RW	1	01 = Pull- down	11 = Pullup and Down
3	OE1_term1	OE1 Pull up or down	RW	0	00 = None	10 = Pullup
2	OE1_term0	OE1 Pull up or down	RW	1	01 = Pull- down	11 = Pullup and Down
l	OE0_term1	OE0 Pull up or down	RW	0	00 = None	10 = Pullup
)	OE0_term0	OE0 Pull up or down	RW	1	01 = Pull- down	11 = Pullup and Down
Byte 1	5: OE Termination Co	ntrol				
Bit	Control Function	Description	Туре	Power Up Condition	0	1
7	OE7_term1	OE7 Pull up or down	RW	0	00 = None	10 = Pullup
5	OE7_term0	OE7 Pull up or down	RW	1	01 = Pull- down	11 = Pullup and Down
5	OE6_term1	OE6 Pull up or down	RW	0	00 = None	10 = Pullup
1	OE6_term0	OE6 Pull up or down	RW	1	01 = Pull- down	11 = Pullup and Down
3	OE5_term1	OE5 Pull up or down	RW	0	00 = None	10 = Pullup
2	OE5_term0	OE5 Pull up or down	RW	1	01 = Pull- down	11 = Pullup and Down
l	OE4_term1	OE4 Pull up or down	RW	0	00 = None	10 = Pullup
)	OE4_term0	OE4 Pull up or down	RW	1	01 = Pull- down	11 = Pullup and Down
Byte 1	6: Power Good Termir	nation Control				
Bit	Control Function	Description	Туре	Power Up Condition	0	1
7:2	Reserved			0x09		
	PWRGD_PD1	Clock Power Good and Power Down Pull up or	RW	1	00 = None	10 = Pullup
)	PWRGD_PD0	Pull down	RW	0	01 = Pull- down	11 = Pullup and Down





Byte 1	Byte 18: Enable Pin Control							
Bit	Control Function	Description	Туре	Power Up Condition	0	1		
7	OE7_Enable	Sets Enable High or Low	RW	0	Enable = Low	Enable = High		
6	OE6_Enable	Sets Enable High or Low	RW	0	Enable = Low	Enable = High		
5	OE5_Enable	Sets Enable High or Low	RW	0	Enable = Low	Enable = High		
4	OE4_Enable	Sets Enable High or Low	RW	0	Enable = Low	Enable = High		
3	OE3_Enable	Sets Enable High or Low	RW	0	Enable = Low	Enable = High		
2	OE2_Enable	Sets Enable High or Low	RW	0	Enable = Low	Enable = High		
1	OE1_Enable	Sets Enable High or Low	RW	0	Enable = Low	Enable = High		
0	OE0_Enable	Sets Enable High or Low	RW	0	Enable = Low	Enable = High		

#### Byte 19: Power Down Pin Control

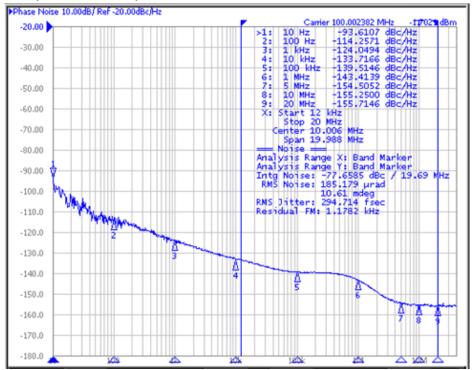
Bit	Control Function	Description	Туре	Power Up Condition	0	1
7:1	Reserved			0		
0	PWRGD_PD	PWRGD_PD Active via Pull up or Pull down	RW	0	Power Down = Low	Power Down = High



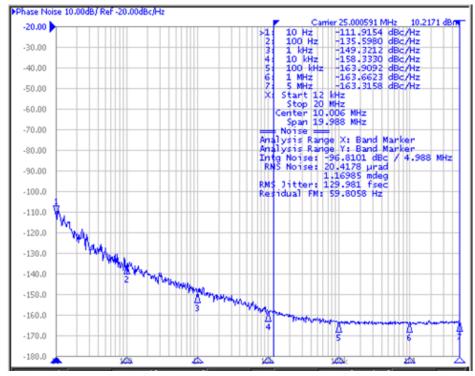


#### **Phase Noise Plots**

## 100MHz HCSL Clock (12k to 20MHz)



#### 25MHz CMOS Clock





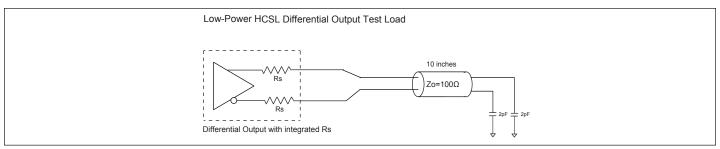


Figure 1. Low Power HCSL Test Circuit

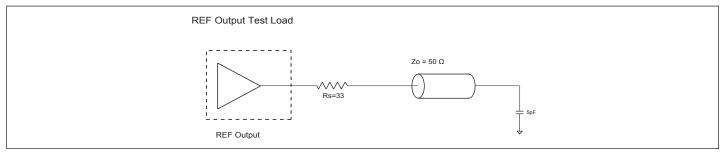


Figure 2. CMOS REF Test Circuit

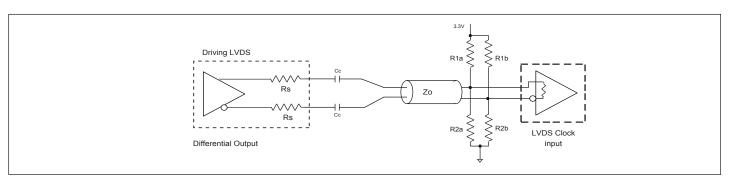
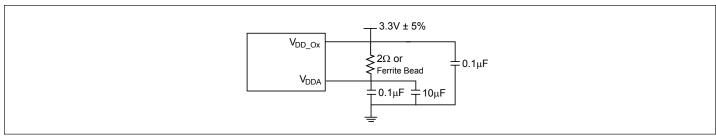


Figure 3. Differential Output driving LVDS

**Table 3. Alternate Differential Output Terminations** 

Component	Receiver with termination	Receiver without termination	Unit
$R_{1a}, R_{1b}$	10,000	140	Ω
$R_{2a}, R_{2b}$	5,600	75	Ω
$C_{\mathbb{C}}$	0.1	0.1	μF
V <sub>CM</sub>	1.2	1.2	V



**Figure 4. Power Supply Filter** 

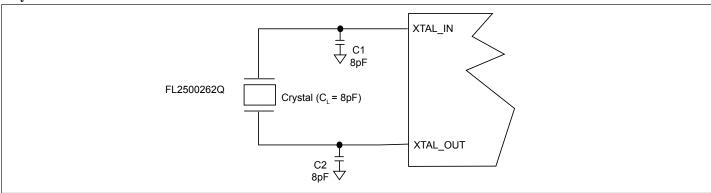




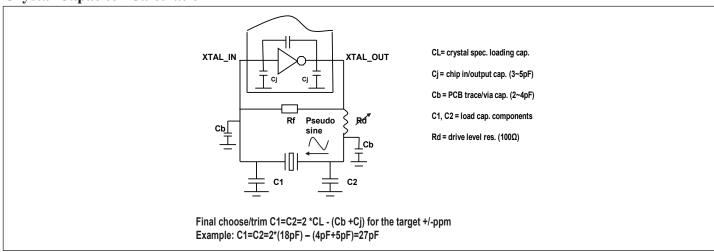
## **Crystal Circuit Connection**

The following diagram shows PI6CG33801C crystal circuit connection with a parallel crystal. For the CL = 8pF crystal, it is suggested to use C1 = 8pF, C2 = 8pF. C1 and C2 can be adjusted to fine tune to the target ppm of crystal oscillator according to different board layouts based on the following formular in the Crystal Capacitor Calculation diagram.

### **Crystal Oscillator Circuit**



#### **Crystal Capacitor Calculation**



## **Recommended Crystal Specification**

#### **Diodes Recommends:**

- a) FL2500217, SMD 3.2x2.5(4P), 25MHz, CL=8pF, +/-20ppm, https://www.diodes.com/assets/Datasheets/FL.pdf
- b) FH2500016, SMD 2.5x2.0(4P), 25MHz, CL=8pF, +/-30ppm, https://www.diodes.com/assets/Datasheets/FH.pdf
- c) FW2500031, SMD 2.0x1.6(4P), 25MHz, CL=8pF, +/-30ppm, https://www.diodes.com/assets/Datasheets/FW.pdf
- d) US2500003, SMD 1.6x1.2(4P), 25MHz, CL=12pF, +/-30ppm, https://www.diodes.com/assets/Datasheets/US.pdf

#### **Table 4. Thermal Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
$\theta_{\mathrm{JA}}$	Thermal Resistance Junction to Ambient	Still air			38.15	°C/W
$\theta_{ m JC}$	Thermal Resistance Junction to Case				24.66	°C/W



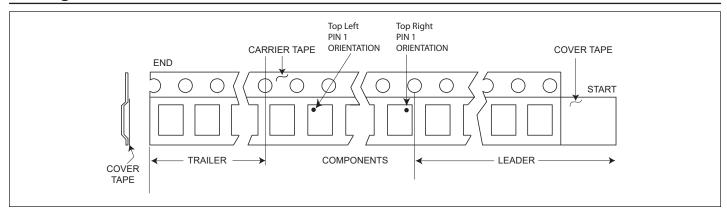


## **Part Marking**



YY: Year WW: Workweek 1st X: Assembly Code 2nd X: Fab Code

## **Package Information**

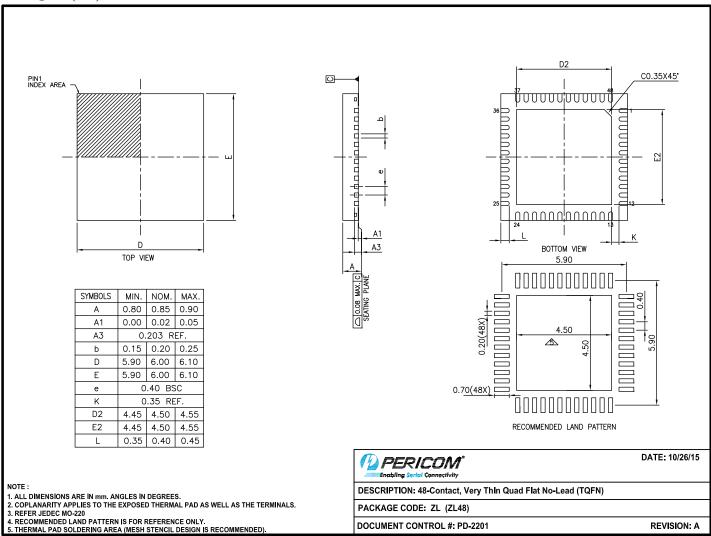






## **Packaging Mechanical**

#### 48-TQFN (ZL)



15-0244

#### For latest package info.

please check: http://www.diodes.com/design/support/packaging/pericom-packaging/packaging-mechanicals-and-thermal-characteristics/

## **Ordering Information**

Ordering Code	ode Package Code Package Description		Pin 1 Location	
PI6CG33801CZLIEX	ZL	48-Contact, Very Thin Quad Flat No-Lead (TQFN)	Top Right Corner	
PI6CG33801CZLIEX-13R	ZL	48-Contact, Very Thin Quad Flat No-Lead (TQFN)	Top Left Corner	

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. E = Pb-free and Green
- 5. X suffix = Tape/Reel
- $6.\ For\ packaging\ details, go\ to\ our\ website\ at:\ https://www.diodes.com/assets/MediaList-Attachments/Diodes-Package-Information.pdf$





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